

Features :

- 10us short circuit capability
- Low switching losses
- $V_{CE(sat)}$ with Positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD

Typical Applications :

- Inverter for motor drive(VFD)
- AC and DC servo drive amplifier
- Uninterruptible power supply

| SYMBOL | CHARACTERISTIC | TEST CONDITIONS | VALUE | | | UNIT |
|---------------|--|--|-------------------------|------|----------|---------------------------|
| | | | Min. | Typ. | Max. | |
| V_{CES} | Collector-Emitter voltage | $T_j=25^\circ\text{C}$ | | | 1200 | V |
| V_{GES} | Gate-Emitter voltage | $T_j=25^\circ\text{C}$ | | | ± 20 | V |
| I_C | Collector current | Continuous@ $T_C=100^\circ\text{C}$ | | | 100 | A |
| I_{CP} | | $t_p=1\text{ms}$ | | | 100 | A |
| P_{tot} | Power Dissipation Per IGBT | $T_C=25^\circ\text{C}$, $T_{vj\ max}=175^\circ\text{C}$ | | | 300 | W |
| T_j | Junction temperature | / | | | 175 | $^\circ\text{C}$ |
| $T_{vj(op)}$ | Temperature under switching conditions | $T_{vj\ op} > 150^\circ\text{C}$ is only allowed for operation at overload conditions. | -40 | | 175 | $^\circ\text{C}$ |
| T_{stg} | Storage temperature | / | -40 | | 150 | $^\circ\text{C}$ |
| V_{iso} | Isolation between terminal and copper base | $T_j=25^\circ\text{C}$, AC: 1minute | 2500 | | | V |
| Screw torque | Mounting(M5) | / | 2.4 | | 3.0 | N·m |
| I_{CES} | Zero gate voltage collector current | $T_j=25^\circ\text{C}$, $V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$ | | | 5 | mA |
| I_{GES} | Gate-Emitter leakage current | $T_j=25^\circ\text{C}$, $V_{CE}=0\text{V}$, $V_{GE}=\pm 20\text{V}$ | -0.4 | | 0.4 | μA |
| $V_{GE(th)}$ | Gate-Emitter threshold voltage | $T_j=25^\circ\text{C}$, $V_{CE}=20\text{V}$, $I_C=1.2\text{mA}$ | 4.6 | 5.2 | 6.0 | V |
| $V_{CE(sat)}$ | Collector-Emitter saturation voltage | $T_j=25^\circ\text{C}$, $V_{GE}=15\text{V}$, $I_C=100\text{A}$ | | 2.1 | 2.5 | V |
| | | $T_j=125^\circ\text{C}$, $V_{GE}=15\text{V}$, $I_C=100\text{A}$ | | 2.4 | 2.5 | V |
| R_{Gint} | Integrated gate resistor | | | 2 | | Ω |
| Q_g | Gate Charge | $T_j=25^\circ\text{C}$, $V_{CE}=600\text{V}$, $I_C=100\text{A}$, $V_{GE}=\pm 15\text{V}$ | | 0.7 | | μC |
| C_{ies} | Input capacitance | $T_j=25^\circ\text{C}$, $V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$, $f=1\text{MHz}$ | | 9.0 | | nF |
| C_{res} | Reverse transfer capacitance | | | 0.47 | | nF |
| $t_{(d)on}$ | Turn-on time | $V_{CC}=600\text{V}$, $I_C=100\text{A}$, $V_{GE}=\pm 15\text{V}$, $R_g=6\Omega$, Inductive load | $T_j=25^\circ\text{C}$ | 35 | | ns |
| | | | $T_j=125^\circ\text{C}$ | 40 | | ns |
| t_r | $T_j=25^\circ\text{C}$ | | 40 | | ns | |
| | $T_j=125^\circ\text{C}$ | | 45 | | ns | |
| $t_{(d)off}$ | Turn-off time | | $T_j=25^\circ\text{C}$ | 240 | | ns |
| | | | $T_j=125^\circ\text{C}$ | 270 | | ns |
| t_f | | | $T_j=25^\circ\text{C}$ | 100 | | ns |
| | | | $T_j=125^\circ\text{C}$ | 130 | | ns |
| t_{sc} | Short circuit withstand time | $V_{GE}=15\text{V}$, $V_{CC}=600\text{V}$ | | 10 | | μs |
| V_F | Forward on voltage | $T_j=25^\circ\text{C}$, $I_F=100\text{A}$ | | 1.85 | 2.15 | V |
| | | $T_j=125^\circ\text{C}$, $I_F=100\text{A}$ | | 1.95 | | V |
| t_{rr} | Diode reverse recovery time | $I_F=100\text{A}$, $V_R=600\text{V}$ $di_F/dt=-600\text{A}/\mu\text{s}$ $T_j=125^\circ\text{C}$ | | 120 | | ns |
| I_{RRM} | Max. reverse recovery current | $I_F=100\text{A}$, $V_R=600\text{V}$ $T_j=125^\circ\text{C}$ | | 37 | | A |
| $R_{th(j-c)}$ | Thermal resistance(per chip) | IGBT | | 0.12 | | $^\circ\text{C}/\text{W}$ |
| | | FWD | | 0.3 | | $^\circ\text{C}/\text{W}$ |
| Outline | M40 | | | | | |

NTC-Thermistor Characteristic Values

| SYMBOL | CHARACTERISTIC | TEST CONDITIONS | VALUE | | | UNIT |
|--------------------|-------------------|--|-------|------|------|------|
| | | | Min. | Typ. | Max/ | |
| R ₂₅ | Rated resistance | T _C =25°C | | 5.00 | | kΩ |
| ΔR/R | Deviation of R100 | T _C =100°C, R ₁₀₀ =493Ω | -5 | | 5 | % |
| P ₂₅ | Power dissipation | T _C =25°C | | | 20.0 | mW |
| B _{25/50} | B-value | $R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{ K}))]$ | | 3375 | | K |

output characteristic IGBT, Inverter (typical)
I_C = f (V_{CE})
V_{GE} = 15 V

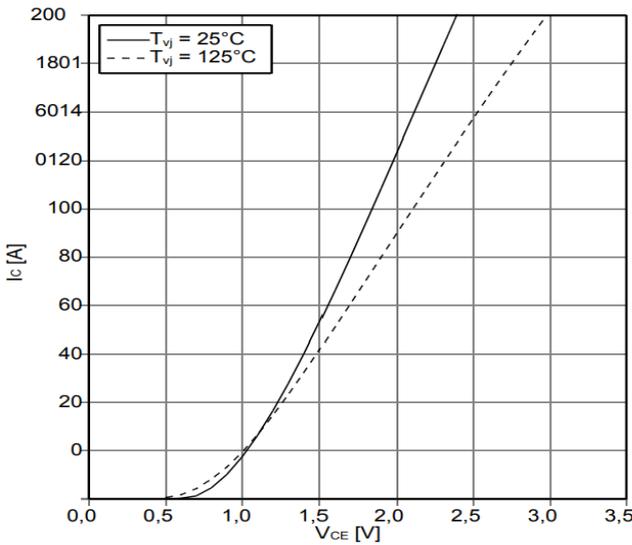


Fig.1

output characteristic IGBT, Inverter (typical)
I_C = f (V_{CE})
T_{vj} = 125°C

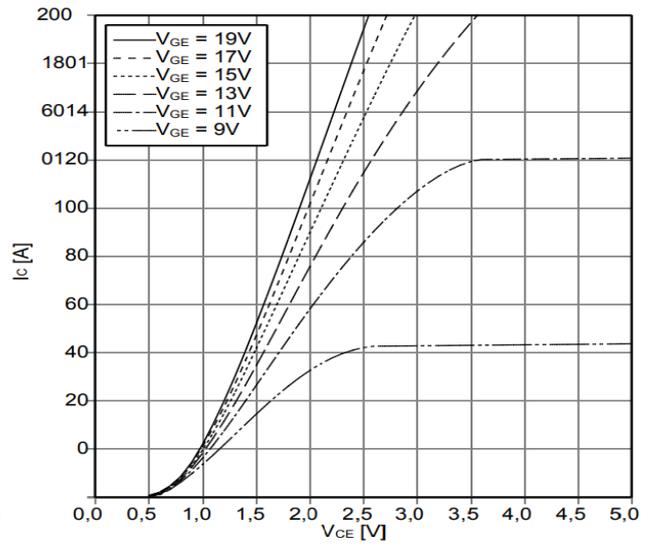


Fig.2

transfer characteristic IGBT, Inverter (typical)
I_C = f (V_{GE})
V_{CE} = 20 V

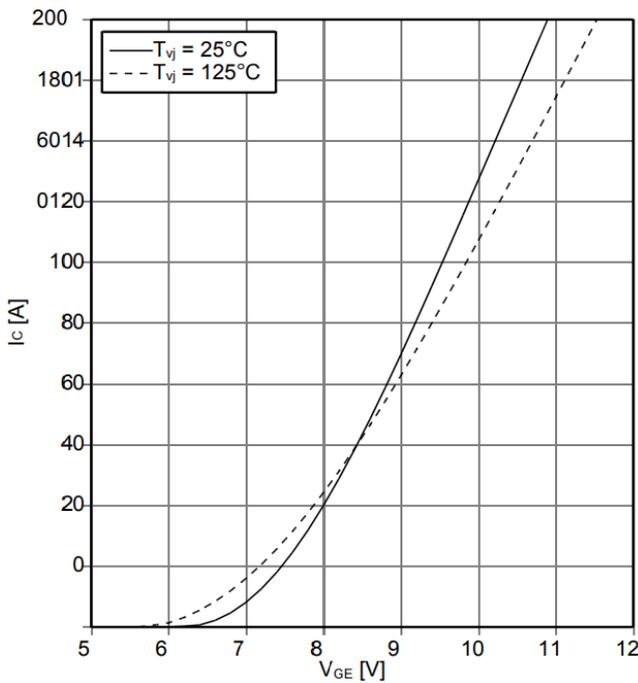


Fig.3

switching losses IGBT, Inverter (typical)
E_{on} = f (I_C), E_{off} = f (I_C)
V_{GE} = ±15 V, R_{Gon} = 3.9 Ω, R_{Goff} = 3.9 Ω, V_{CE} = 600 V

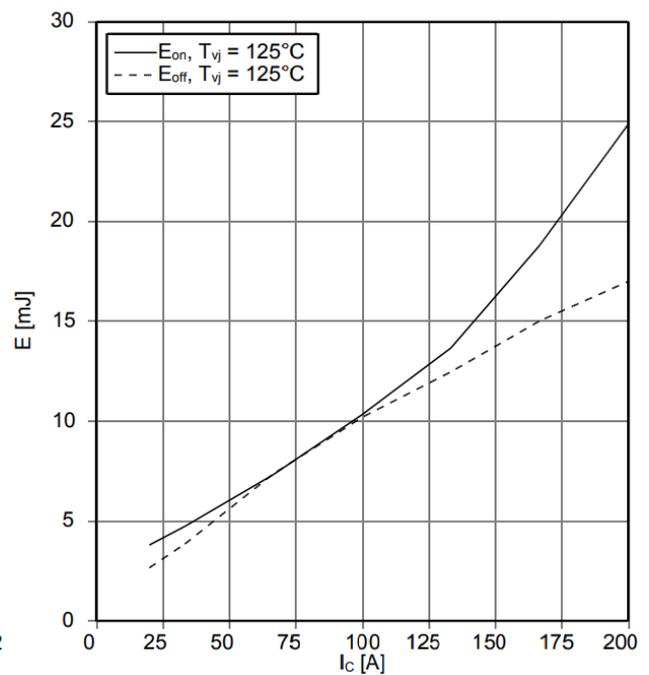


Fig.4

switching losses IGBT, Inverter (typical)

$E_{on} = f(R_G), E_{off} = f(R_G)$
 $V_{GE} = \pm 15 V, I_C = 100 A, V_{CE} = 600 V$

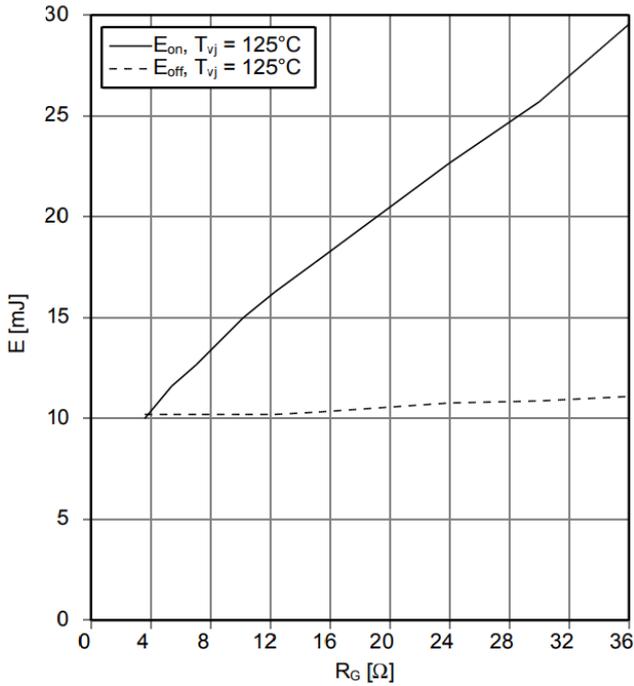


Fig.5

transient thermal impedance IGBT, Inverter

$Z_{thJC} = f(t)$

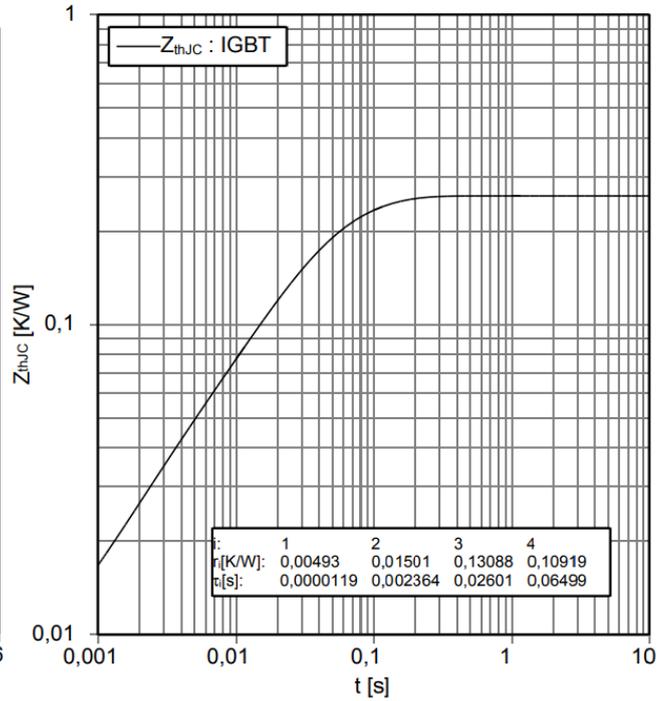


Fig.6

reverse bias safe operating area IGBT, Inverter (RBSOA)

$I_C = f(V_{CE})$
 $V_{GE} = \pm 15 V, R_{Goff} = 3.9 \Omega, T_{vj} = 125^\circ C$

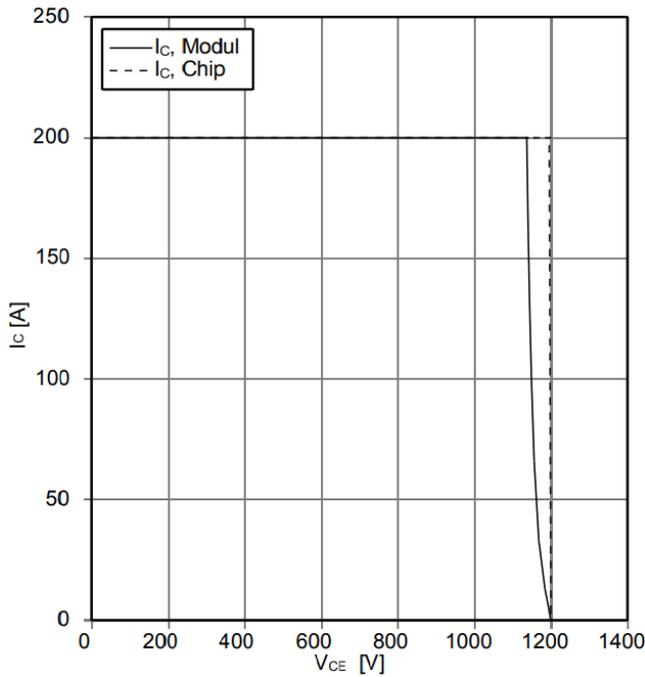


Fig.7

forward characteristic of Diode, Inverter (typical)

$I_F = f(V_F)$

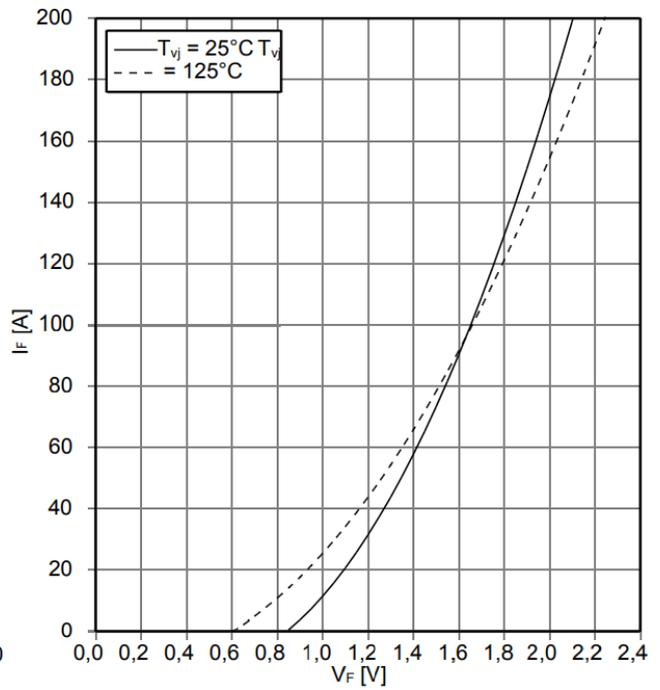


Fig.8

switching losses Diode, Inverter (typical)

$E_{rec} = f(I_F)$
 $R_{Gon} = 3.9 \Omega, V_{CE} = 600 V$

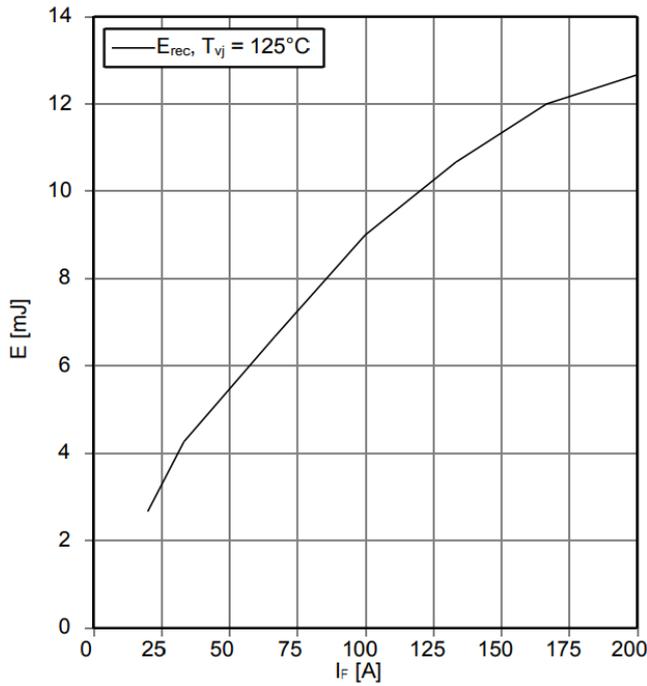


Fig.9

switching losses Diode, Inverter (typical)

$E_{rec} = f(R_G)$
 $I_F = 100 A, V_{CE} = 600 V$

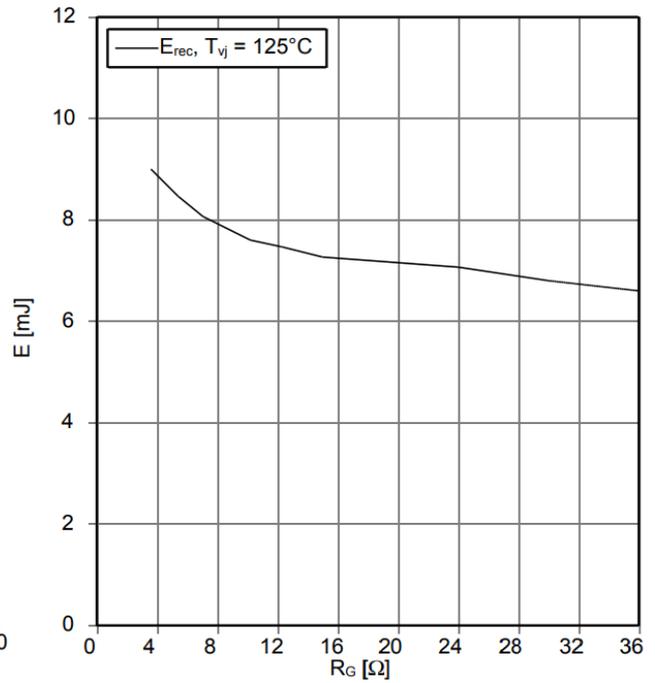


Fig.10

transient thermal impedance Diode, Inverter

$Z_{thJC} = f(t)$

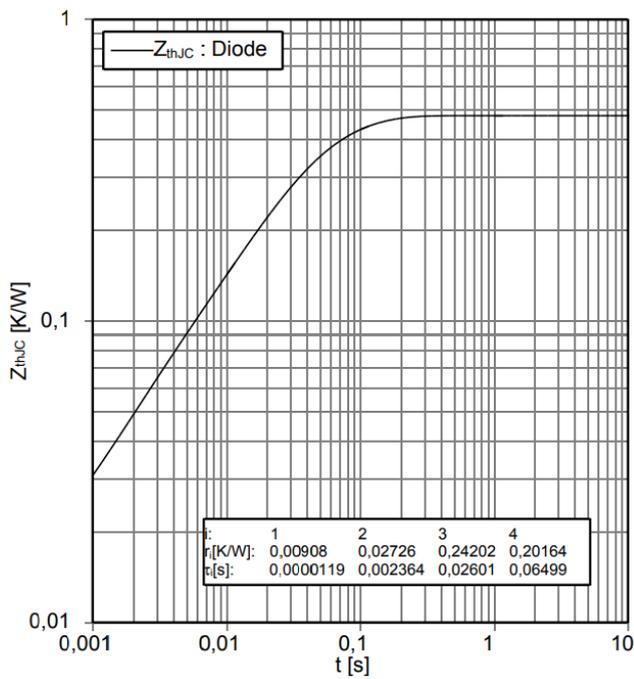
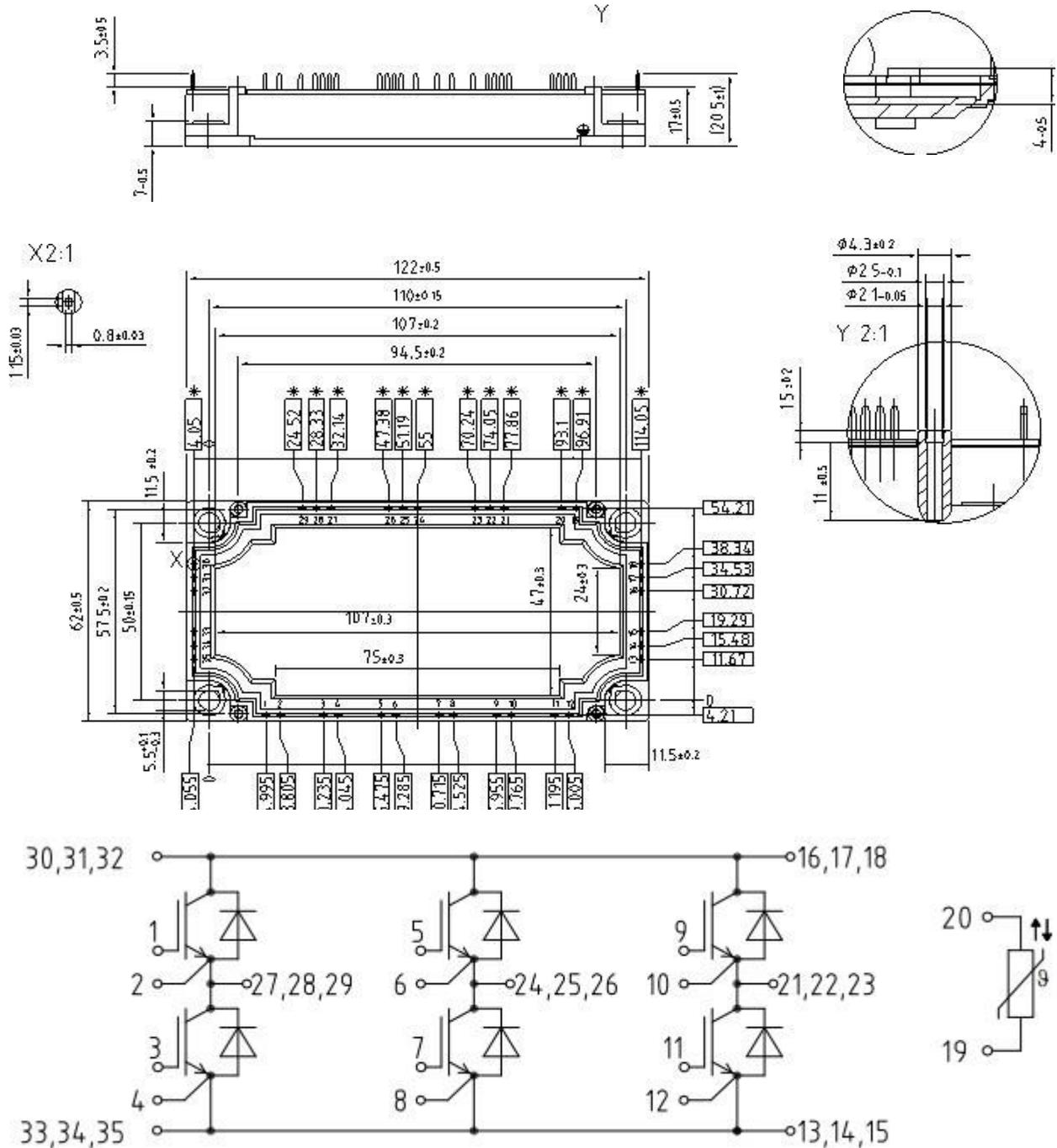


Fig.11



Unmarked dimensional tolerance : ±0.5mm